

SEMiX 352GB128Ds



SEMiX® 2s

SPT IGBT Modules

SEMiX 352GB128Ds

SEMiX 352GAL128Ds

SEMiX 352GAR128Ds

Preliminary Data

Features

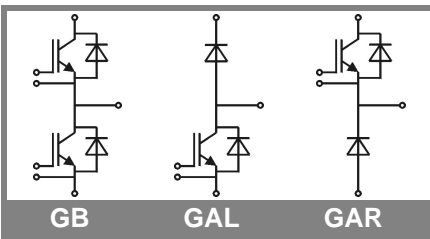
- Homogeneous Si
- SPT = Soft-Punch-Through technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

- AC inverter drives
- UPS
- Electronic welders up to 20 kHz

Absolute Maximum Ratings		$T_{case} = 25^{\circ}C$, unless otherwise specified		
Symbol	Conditions	Values	Units	
IGBT				
V_{CES}	$T_j = 25^{\circ}C$	1200	V	
I_C	$T_j = 150^{\circ}C$	$T_{case} = 25^{\circ}C$	370	A
		$T_{case} = 80^{\circ}C$	260	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	400	A	
V_{GES}		± 20	V	
t_{psc}	$V_{CC} = 600 V$; $V_{GE} \leq 20 V$; $T_j = 125^{\circ}C$ $V_{CES} < 1200 V$	10	μs	
Inverse Diode				
I_F	$T_j = 150^{\circ}C$	$T_{case} = 25^{\circ}C$	270	A
		$T_{case} = 80^{\circ}C$	180	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	400	A	
I_{FSM}	$t_p = 10 ms$; sin.	$T_j = 25^{\circ}C$	2000	A
Module				
$I_{t(RMS)}$		600	A	
T_{vj}		-40 ... +150	$^{\circ}C$	
T_{stg}		-40 ... +125	$^{\circ}C$	
V_{isol}	AC, 1 min.	4000	V	

Characteristics		$T_{case} = 25^{\circ}C$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 8 mA$	4,5	5	6,5	V
I_{CES}	$V_{GE} = 0 V$, $V_{CE} = V_{CES}$			0,3	mA
V_{CE0}		$T_j = 25^{\circ}C$	1	1,15	V
		$T_j = 125^{\circ}C$	0,9	1,05	V
r_{CE}	$V_{GE} = 15 V$	$T_j = 25^{\circ}C$	4,5	6	m Ω
		$T_j = 125^{\circ}C$	6	7,5	m Ω
$V_{CE(sat)}$	$I_{Cnom} = 200 A$, $V_{GE} = 15 V$	$T_j = 25^{\circ}C_{chiplev.}$	1,9	2,35	V
		$T_j = 125^{\circ}C_{chiplev.}$	2,3	2,55	V
C_{ies}	$V_{CE} = 25$, $V_{GE} = 0 V$	$f = 1 MHz$	16		nF
C_{oes}			3		nF
C_{res}			2		nF
Q_G	$V_{GE} = -8 V \dots +15 V$		1900		nC
$t_{d(on)}$	$R_{Gon} = 3 \Omega$	$V_{CC} = 600V$ $I_{Cnom} = 200A$	230		ns
t_r			55		ns
E_{on}	$R_{Goff} = 3 \Omega$	$T_j = 125^{\circ}C$	20		mJ
$t_{d(off)}$			585		ns
t_f			90		ns
E_{off}			21		mJ
$R_{th(j-c)}$	per IGBT			0,085	K/W



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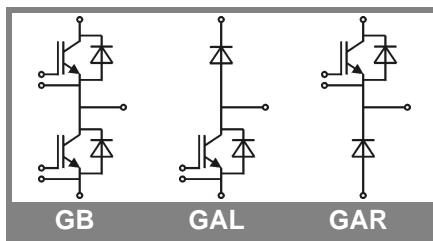
Typical Applications

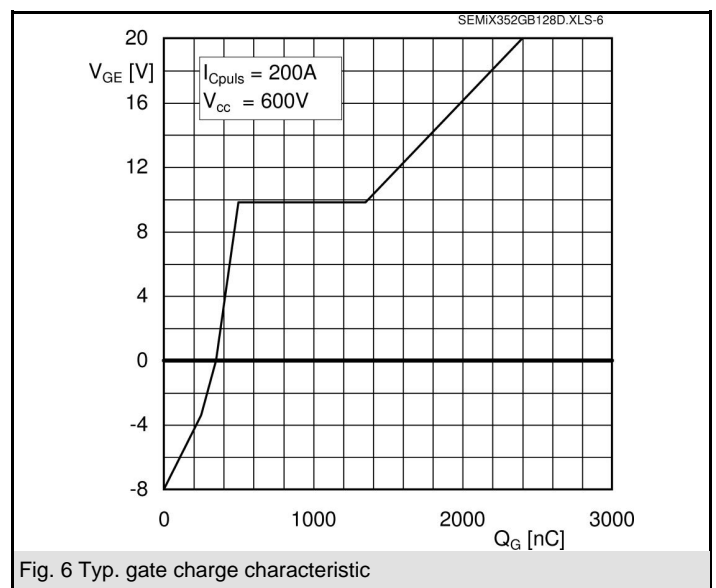
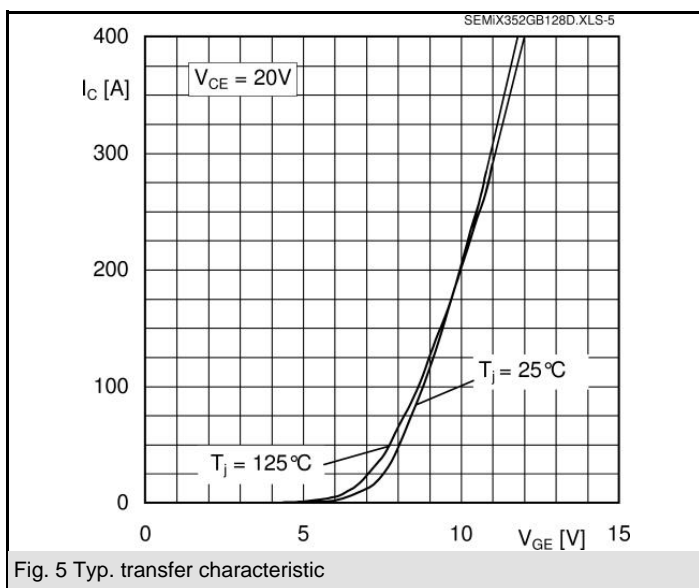
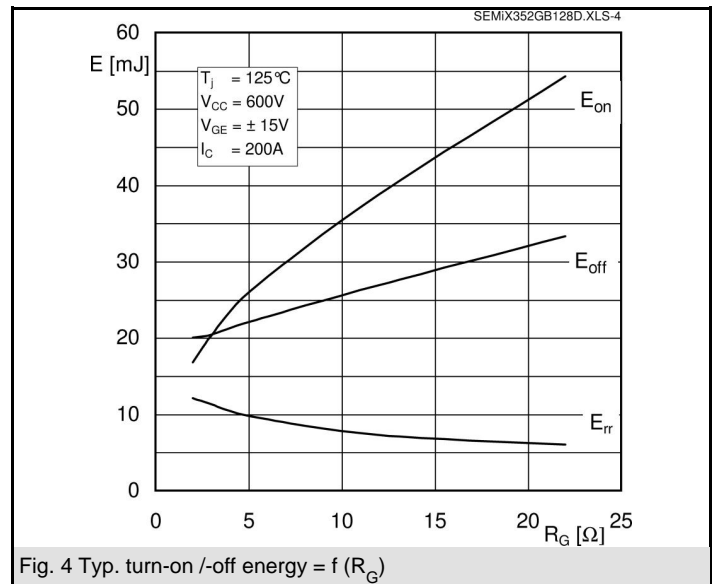
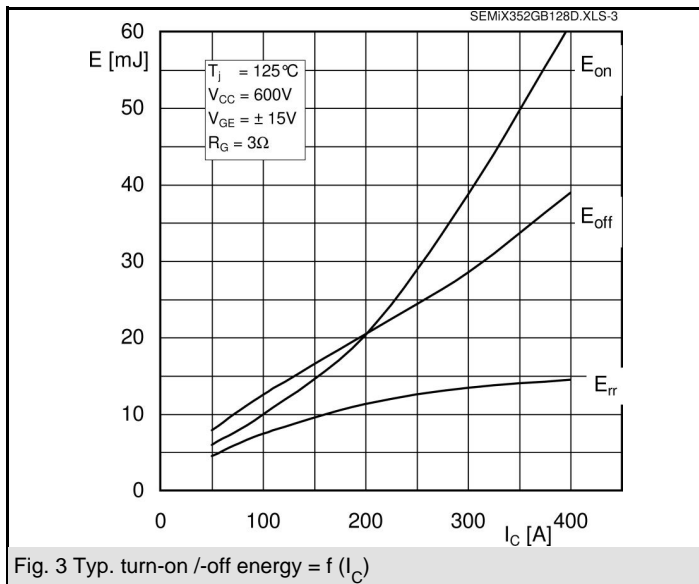
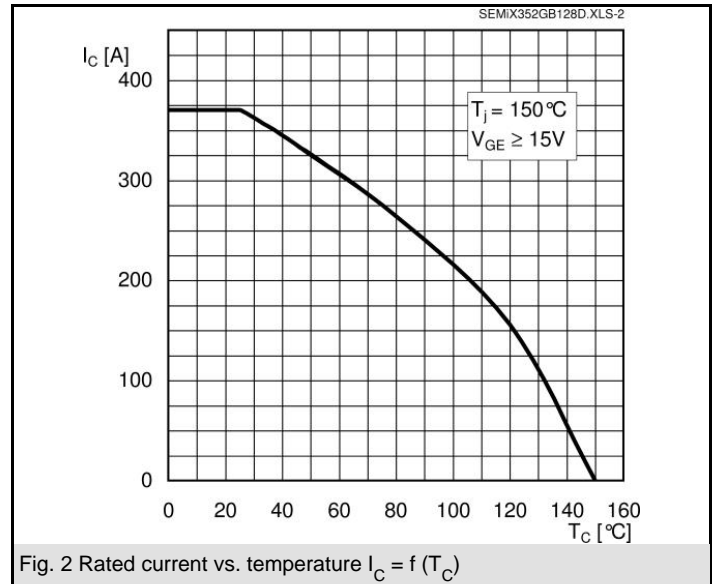
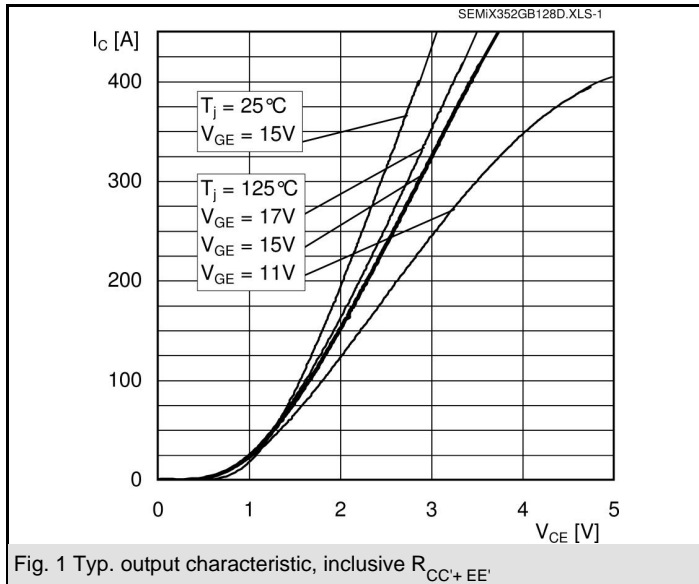
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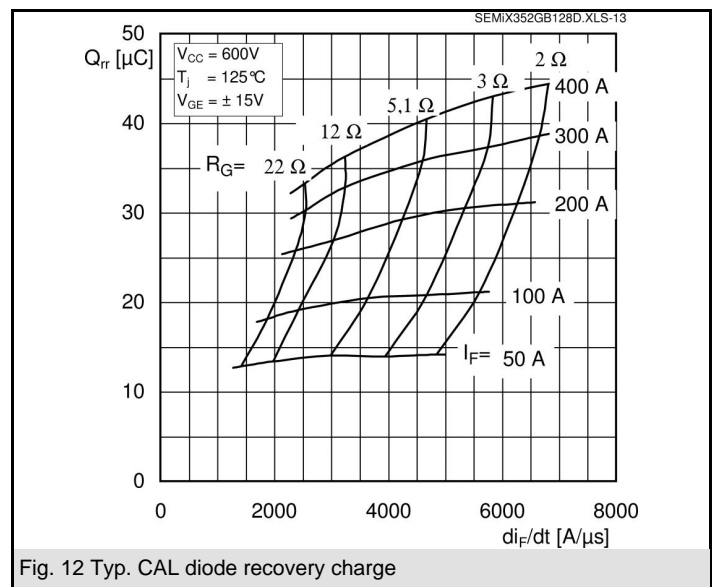
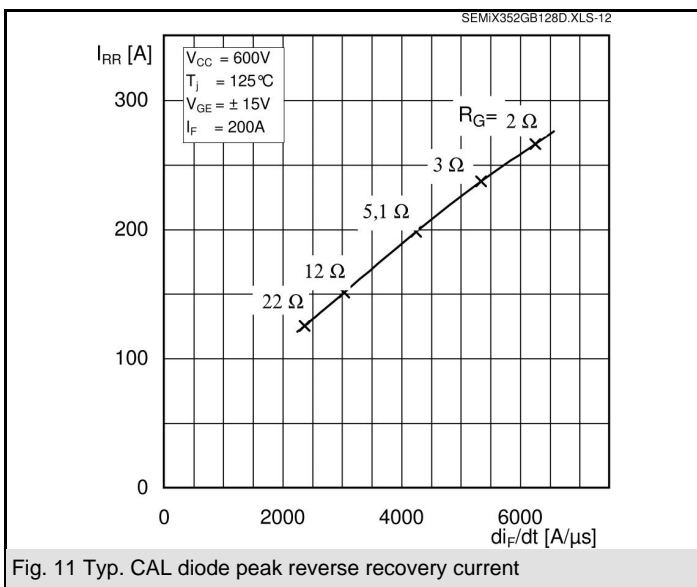
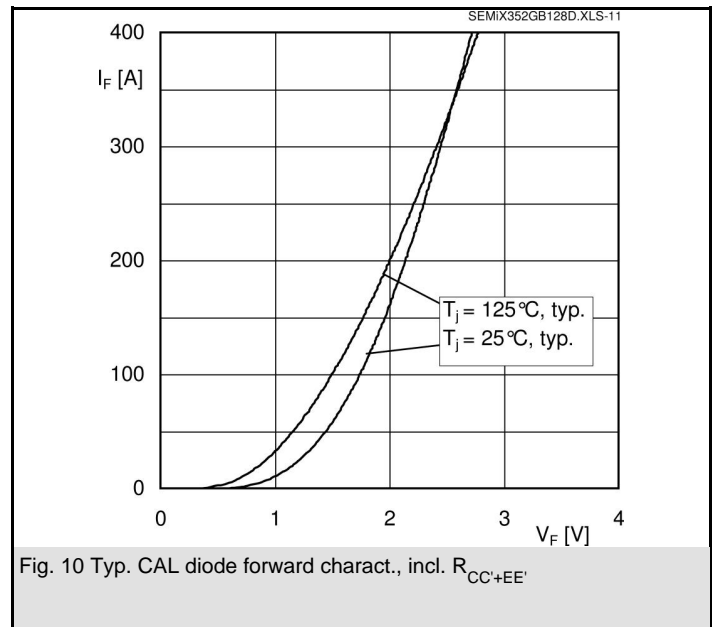
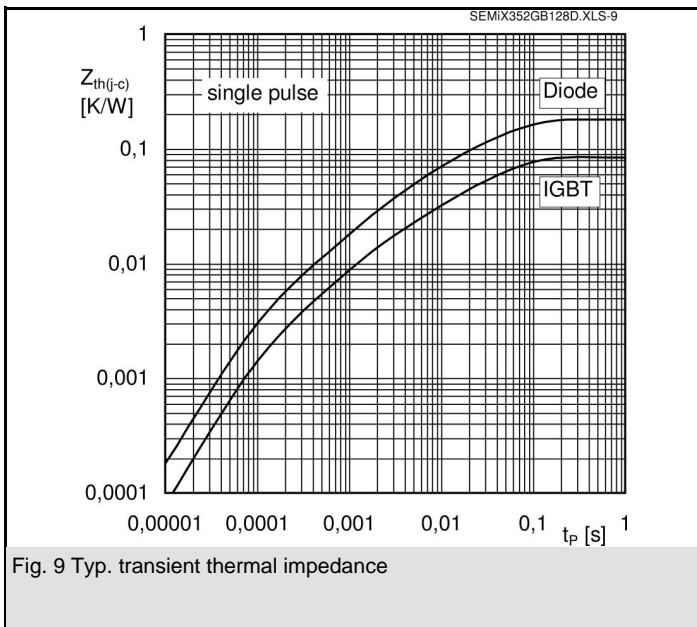
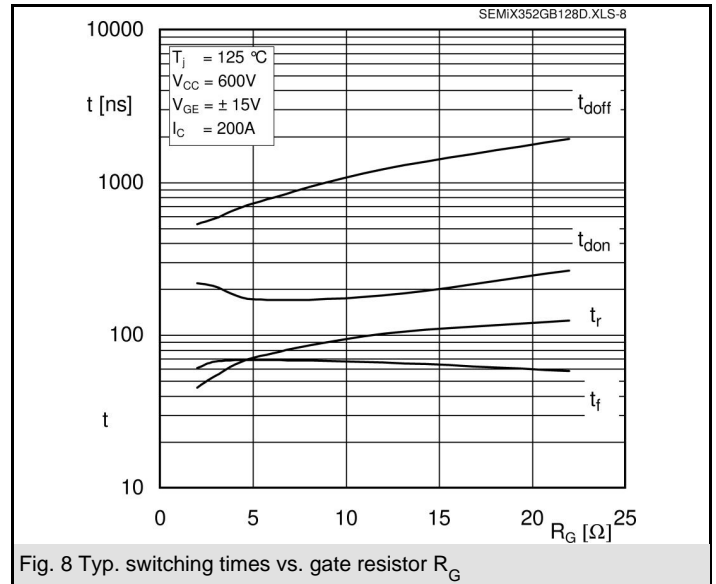
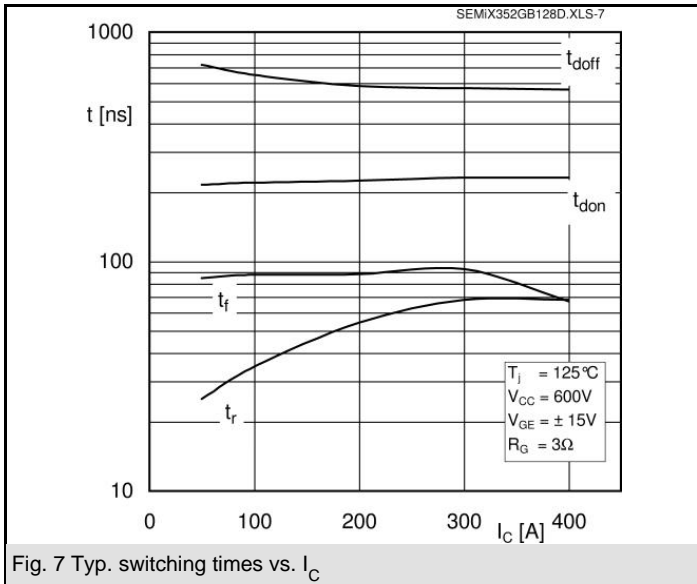
Characteristics		min.	typ.	max.	Units
Inverse Diode					
$V_F = V_{EC}$	$I_{Fnom} = 200 \text{ A}; V_{GE} = 0 \text{ V}$		2	2,5	V
	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$				
	$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$		1,8	2,3	V
V_{F0}			1,1	1,2	V
	$T_j = 25 \text{ }^\circ\text{C}$				
	$T_j = 125 \text{ }^\circ\text{C}$				V
r_F			4,5	6,5	mΩ
	$T_j = 25 \text{ }^\circ\text{C}$				
	$T_j = 125 \text{ }^\circ\text{C}$				mΩ
I_{RRM}	$I_{Fnom} = 225 \text{ A}$		240		A
Q_{rr}	$di/dt = 5300 \text{ A}/\mu\text{s}$		31		μC
E_{off}	$V_{GE} = -15 \text{ V}; V_{CC} = 600 \text{ V}$		11		mJ
$R_{th(j-c)D}$	per diode			0,18	K/W
Module					
L_{CE}			18		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_{case} = 25 \text{ }^\circ\text{C}$	0,7		mΩ
		$T_{case} = 125 \text{ }^\circ\text{C}$	1		mΩ
$R_{th(c-s)}$	per module		0,045		K/W
M_s	to heat sink (M5)		3	5	Nm
M_t	to terminals (M6)		2,5	5	Nm
w			289	250	g
Temperature sensor					
R_{100}	$T_c = 100 \text{ }^\circ\text{C}$ ($R_{25} = 5 \text{ k}\Omega$)		0,493±5%		kΩ
$B_{100/125}$	$R(T) = R_{100} \exp[B_{100/125} (1/T - 1/T_{100})]$; $T[\text{K}]; B$		3550±2%		K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.





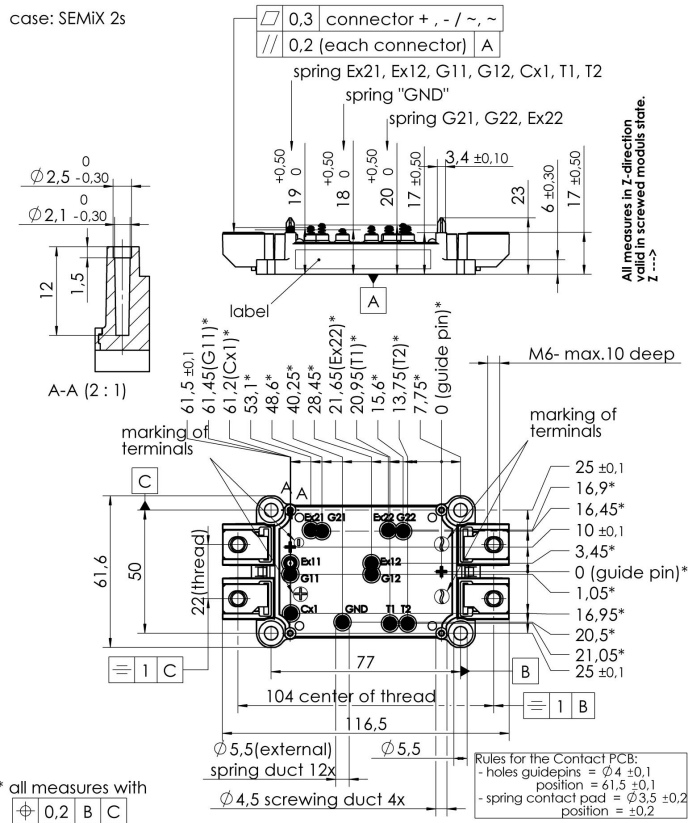


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UL Recognized
File no. E 63 532

Dimensions in mm

case: SEMiX 2s



Case SEMiX 2s

